Power MOSFET

30 V, 207 A, Single N-Channel, SO-8 FL

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Server, Netcom, POL
- Synchronous Rectification for DC-DC Converters
- Low Side Switching
- High Performance Applications

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	36	Α
Current R _{θJA} (Note 1)		T _A = 85°C		26	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.7	W
Continuous Drain		T _A = 25°C	I _D	60	Α
Current R _{θJA} ≤ 10 sec		T _A = 85°C		43	
Power Dissipation $R_{\theta JA}$, $t \le 10$ sec	Steady	T _A = 25°C	P _D	7.4	W
Continuous Drain	State	T _A = 25°C	I _D	26.5	Α
Current R _{θJA} (Note 2)		T _A = 85°C	1	19	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	1.5	W
Continuous Drain		T _C = 25°C	I _D	207	Α
Current R _{θJC} (Note 1)		T _C = 85°C	1	149	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	89.3	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	350	Α
Current limited by pack	Current limited by package T _A = 25°C			100	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	54	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_{L} = 50 A_{pk} , L = 0.1 mH, R_{G} = 25 Ω)			EAS	125	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

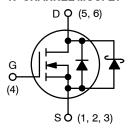


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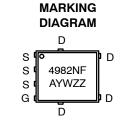
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	1.3 m Ω @ 10 V	207 A
30 V	1.9 mΩ @ 4.5 V	207 A

N-CHANNEL MOSFET







= Assembly Location

= Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4982NFT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4982NFT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.4	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	46.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	84.1	°C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	16.8	

- Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					1	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ mA}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 10 mA, referenced to 25°C			15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \ V_{DS} = 24 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$				500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 1.0 \text{ mA}$		1.0	1.7	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 10 mA, referenced to 25°C			5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 25 A		0.95	1.3	mΩ
		V _{GS} = 4.5 V	I _D = 25 A		1.4	1.9	
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			60		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			6000		pF
Output Capacitance	C _{OSS}				2400		
Reverse Transfer Capacitance	C _{RSS}				160		
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 25 A			40		nC
Threshold Gate Charge	Q _{G(TH)}				8.8		
Gate-to-Source Charge	Q_{GS}				15		
Gate-to-Drain Charge	Q_{GD}				12		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 25 A			84		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 25 A, R_{G} = 3 Ω			17.2		
Rise Time	t _r				31.6		ns
Turn-Off Delay Time	t _{d(OFF)}				34.3		
Fall Time	t _f				12		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 25 A, R_{G} = 3 Ω			12.7		
Rise Time	t _r				20.4		ns
Turn-Off Delay Time	t _{d(OFF)}				38.6		
Fall Time	t _f				11.3		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

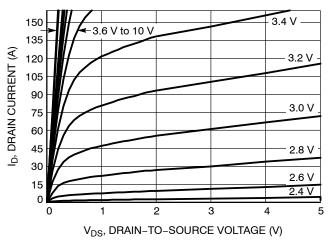
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 2 A	$T_J = 25^{\circ}C$		0.4	0.7	.,,	
			T _J = 125°C		0.32		V	
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/μs, I _S = 25 A			58		ns	
Charge Time	t _a				29			
Discharge Time	t _b				29			
Reverse Recovery Charge	Q _{RR}				71		nC	
PACKAGE PARASITIC VALUES								
Source Inductance	L _S	T _A = 25°C			0.65		nH	
Drain Inductance	L _D				0.20			
Gate Inductance	L _G				1.5			
Gate Resistance	R_{G}				0.8		Ω	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{4.} Switching characteristics are independent of operating junction temperatures.

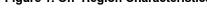
TYPICAL CHARACTERISTICS

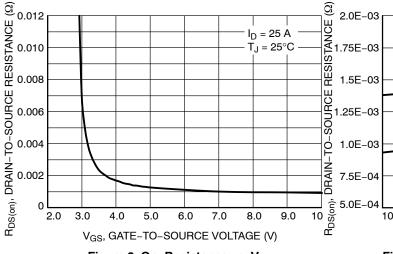


200 180 $V_{DS} = 5 V$ 160 ID, DRAIN CURRENT (A) 140 120 100 80 $T_J = 125^{\circ}C$ 60 T_J = −55°C T_J = 25°C 40 20 1.0 1.5 3.0 2.0 2.5 3.5 4.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics





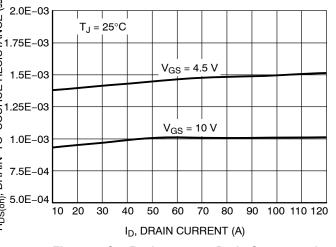
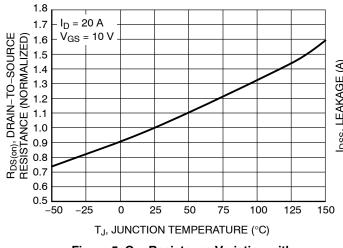


Figure 3. On-Resistance vs. V_{GS}





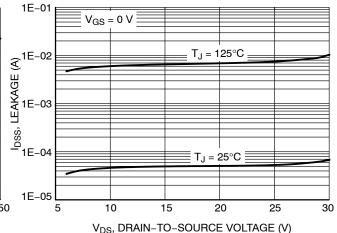


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

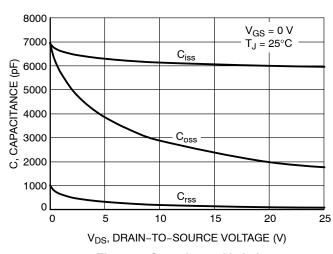


Figure 7. Capacitance Variation

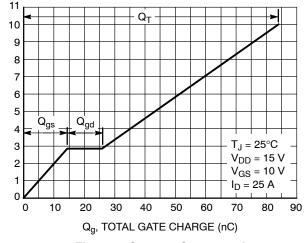


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

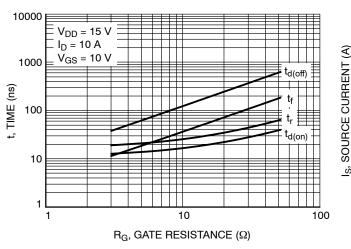


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

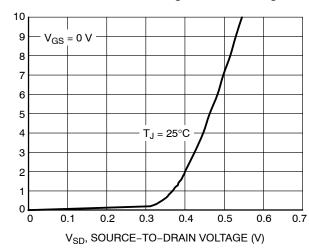


Figure 10. Diode Forward Voltage vs. Current

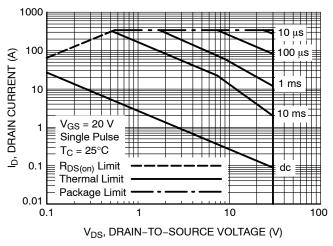


Figure 11. Maximum Rated Forward Biased Safe Operating Area

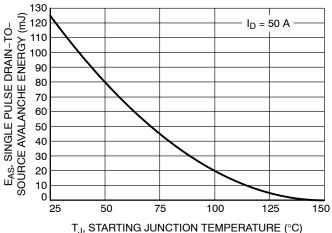


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

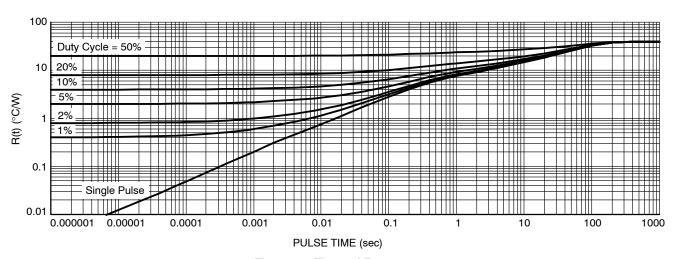
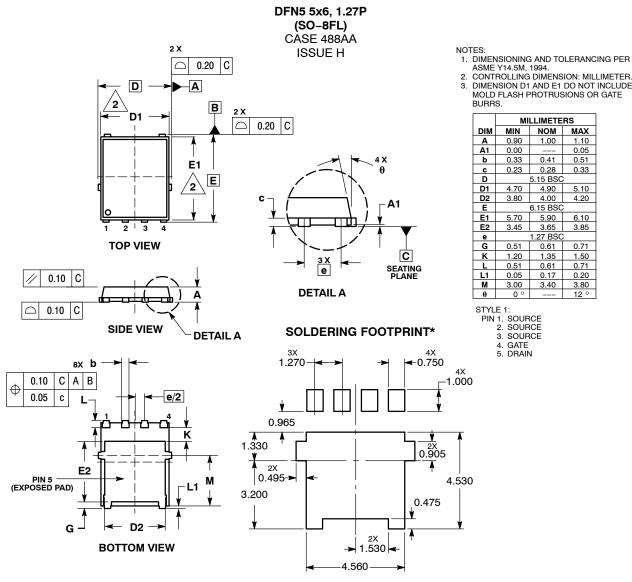


Figure 13. Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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